

# **Protection Device**

TVS (Transient Voltage Suppressor)

# ESD113-B1 Series

Bi-directional, 3.6 V, 0.2 pF, 0201, 0402, RoHS and Halogen Free compliant

ESD113-B1-02ELS ESD113-B1-02EL

# **Data Sheet**

Revision 1.2, 2014-05-14 Final

# Power Management & Multimarket

Edition 2014-05-14
Published by
Infineon Technologies AG
81726 Munich, Germany
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**Product Overview** 

### 1 Product Overview

### 1.1 Features

- ESD / transient protection of high speed data lines according to:
  - IEC61000-4-2 (ESD): ±20 kV (air / contact)
  - IEC61000-4-4 (EFT): ±2.5 kV / ±50 A (5/50 ns)
  - IEC61000-4-5 (surge): ±3 A (8/20 μs)
- Bi-directional, working voltage up to:  $V_{\text{RWM}}$  = ±3.6 V
- Ultra low capacitance  $C_L$  = 0.20 pF (typical) at f = 1 GHz
- Very low clamping voltage:  $V_{\rm CL}$  = 14 V (typical) at  $I_{\rm TLP}$  = 16 A
- Very low reverse current.  $I_R$  < 1 nA (typical)
- Very low dynamic resistance:  $R_{\rm DYN}$  = 0.45  $\Omega$  (typical)
- Pb-free and halogen-free package (RoHS compliant)





### 1.2 Application Examples

- USB 3.0, Firewire, DVI, HDMI, S-ATA, DisplayPort, Thunderbolt
- Mobile HDMI Link, MDDI, MIPI, SWP / NFC

### 1.3 Product Description

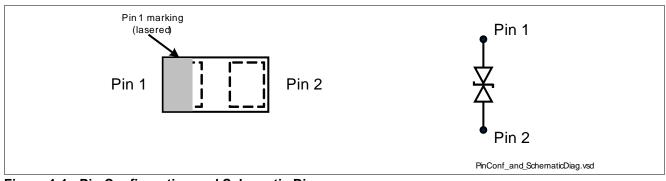


Figure 1-1 Pin Configuration and Schematic Diagram

### Table 1-1 Part Information

Туре	Package	Configuration	Marking code
ESD113-B1-02ELS	TSSLP-2-4	1 line, bi-directional	2
ESD113-B1-02EL	TSLP-2-20	1 line, bi-directional	CC



**Maximum Ratings** 

### 2 Maximum Ratings

**Table 2-1** Maximum Rating at  $T_A = 25$  °C, unless otherwise specified<sup>1)</sup>

Parameter	Symbol	Values	Unit	
ESD air discharge <sup>2)</sup> ESD contact discharge <sup>2)</sup>	$V_{ESD}$	±20 ±20	kV	
Peak pulse power	$P_{PK}$	36	W	
Peak pulse current <sup>3)</sup>	$I_{PP}$	±3	А	
Operating temperature	$T_{OP}$	-55 to 125	°C	
Storage temperature	$T_{ m stg}$	-65 to 150	°C	

- 1) Device is electrically symmetrical
- 2) V<sub>ESD</sub> according to IEC61000-4-2
- 3) Non-repetitive current pulse 8/20 µs exponential decay waveform according to IEC61000-4-5

Attention: Stresses above the max. values listed here may cause permanent damage to the device.

Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Maximum ratings are absolute ratings; exceeding only one of these values may cause irreversible damage to the component.

### 3 Electrical Characteristics at $T_A = 25$ °C, unless otherwise specified

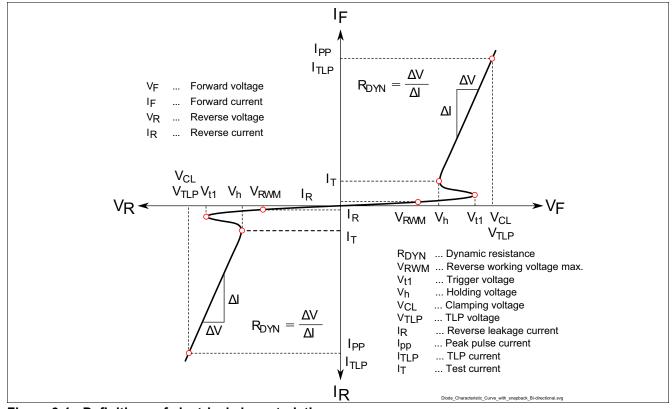


Figure 3-1 Definitions of electrical characteristics



### Electrical Characteristics at $T_A$ = 25 °C, unless otherwise specified

**Table 3-1 DC Characteristics** at  $T_A = 25$  °C, unless otherwise specified <sup>1)</sup>

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Тур.	Max.		
Reverse working voltage	$V_{RWM}$	-3.6	_	3.6	V	
Trigger voltage	$V_{\rm t1}$	4	_	_		
Holding voltage	$V_h$	4	4.6	5.5		$I_{T}$ = 10 mA
Reverse leakage current	$I_{R}$	_	<1	20	nA	V <sub>R</sub> = 3.3 V

<sup>1)</sup> Device is electrically symmetrical

**Table 3-2** AC Characteristics at  $T_A = 25$  °C, unless otherwise specified

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Тур.	Max.		
Line capacitance	$C_{L}$	_	0.2	0.35	pF	$V_{\rm R}$ = 0 V, $f$ = 1 MHz
		_	0.2	_		$V_{\rm R}$ = 0 V, $f$ = 1 GHz
Series inductance	$L_{S}$	_	0.2	_	nH	ESD113-B1-02ELS
		_	0.4	_		ESD113-B1-02EL

**Table 3-3 ESD and Surge Characteristics** at  $T_A = 25$  °C, unless otherwise specified <sup>1)</sup>

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Тур.	Max.		
Clamping voltage <sup>2)</sup>	$V_{CL}$	_	14	_	V	$I_{\text{TLP}} = 16 \text{ A}, t_{\text{p}} = 100 \text{ ns}$
		_	20	_		$I_{\text{TLP}} = 30 \text{ A}, t_{\text{p}} = 100 \text{ ns}$
Clamping voltage <sup>3)</sup>		_	6	_		$I_{PP} = 1 \text{ A}, t_p = 8/20 \mu\text{s}$
		_	8	_		$I_{PP} = 3 \text{ A}, t_p = 8/20 \mu\text{s}$
Dynamic resistance <sup>2)</sup>	$R_{DYN}$	_	0.45	_	Ω	$t_{\rm p} = 100  \rm ns$

<sup>1)</sup> Device is electrically symmetrical

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<sup>2)</sup> Please refer to Application Note AN210[1].TLP parameter:  $Z_0$  = 50  $\Omega$  ,  $t_{\rm p}$  = 100ns,  $t_{\rm r}$  = 300ps.

<sup>3)</sup> Non-repetitive current pulse 8/20µs exponential decay waveform according to IEC61000-4-5



### 4 Typical Characteristics Diagrams

Typical characteristics diagrams at T<sub>A</sub>=25°C, unless otherwise specified

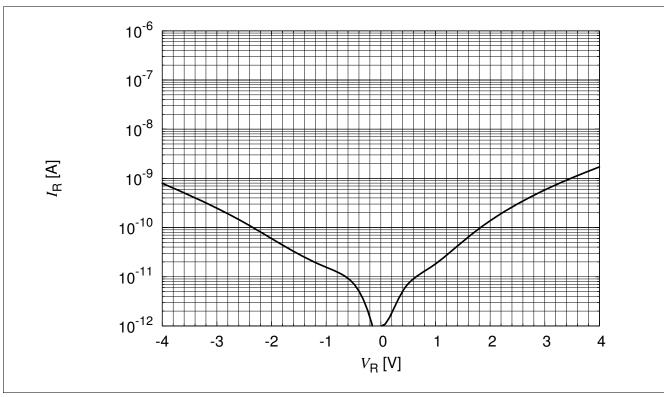


Figure 4-1 Reverse leakage current  $I_R = f(V_R)$ 

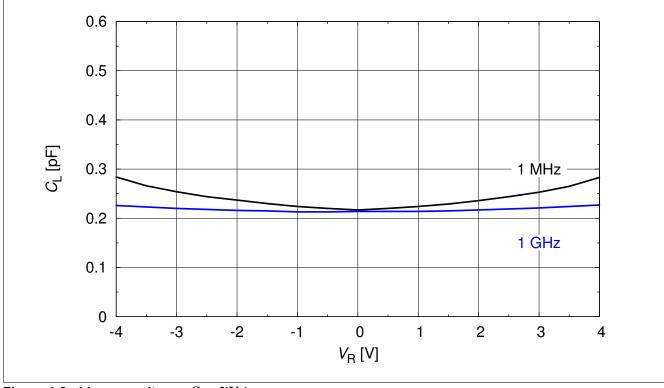


Figure 4-2 Line capacitance  $C_L = f(V_R)$ 



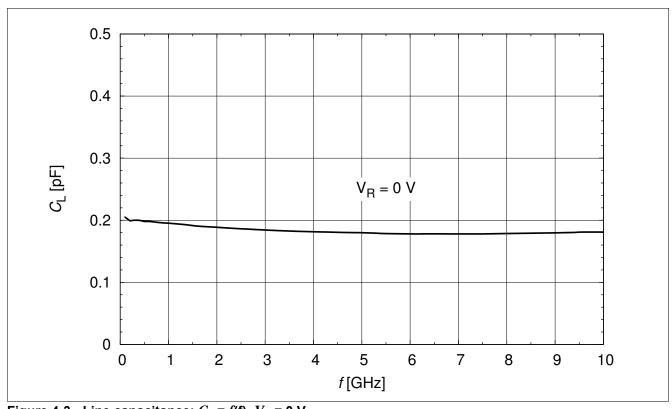


Figure 4-3 Line capacitance:  $C_L = f(f)$ ,  $V_R = 0$  V

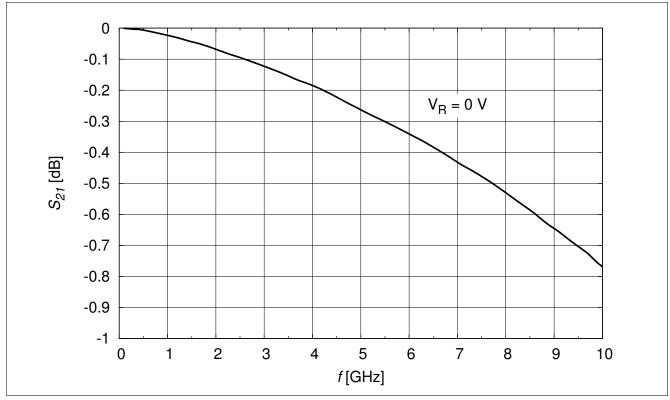


Figure 4-4 Insertion loss vs. frequency in a 50  $\Omega$  system



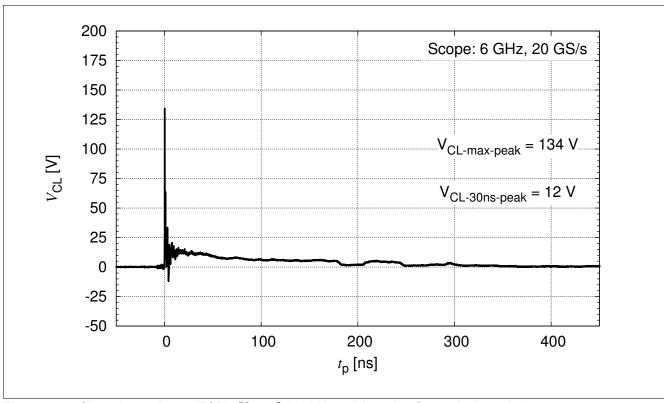


Figure 4-5 Clamping voltage (ESD):  $V_{CL} = f(t)$ , 8 kV positiv pulse from pin 1 to pin 2

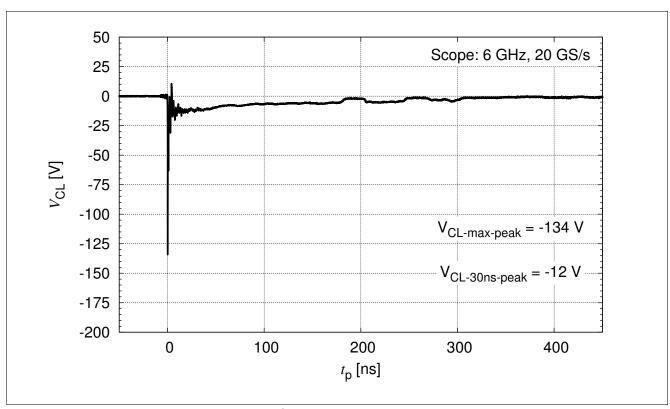


Figure 4-6 Clamping voltage (ESD):  $V_{CL} = f(t)$ , 8 kV negative pulse from pin 1 to pin 2



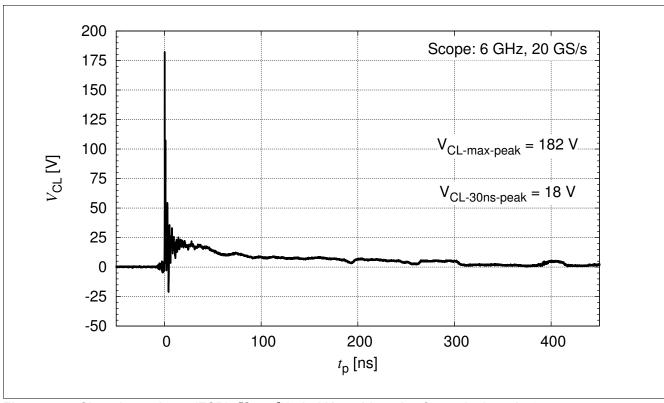


Figure 4-7 Clamping voltage (ESD):  $V_{CL} = f(t)$ , 15 kV positiv pulse from pin 1 to pin 2

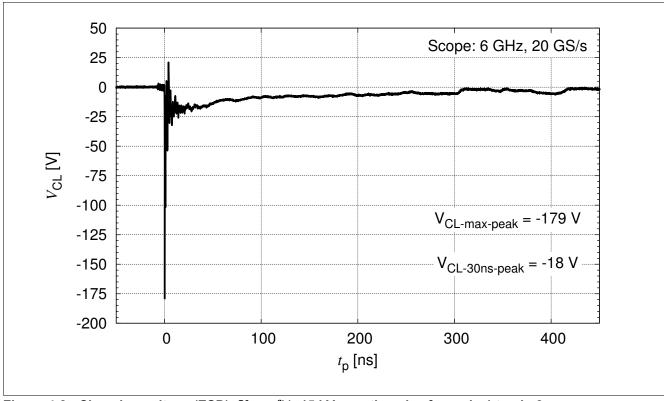


Figure 4-8 Clamping voltage (ESD):  $V_{CL} = f(t)$ , 15 kV negativ pulse from pin 1 to pin 2



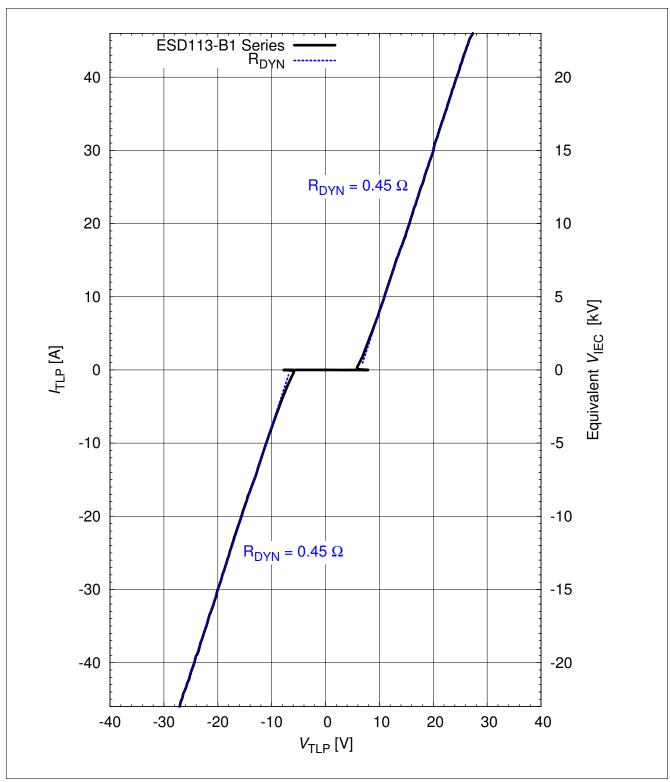


Figure 4-9 Clamping voltage (TLP):  $I_{TLP} = f(V_{TLP})$  [1], pin 1 to pin 2



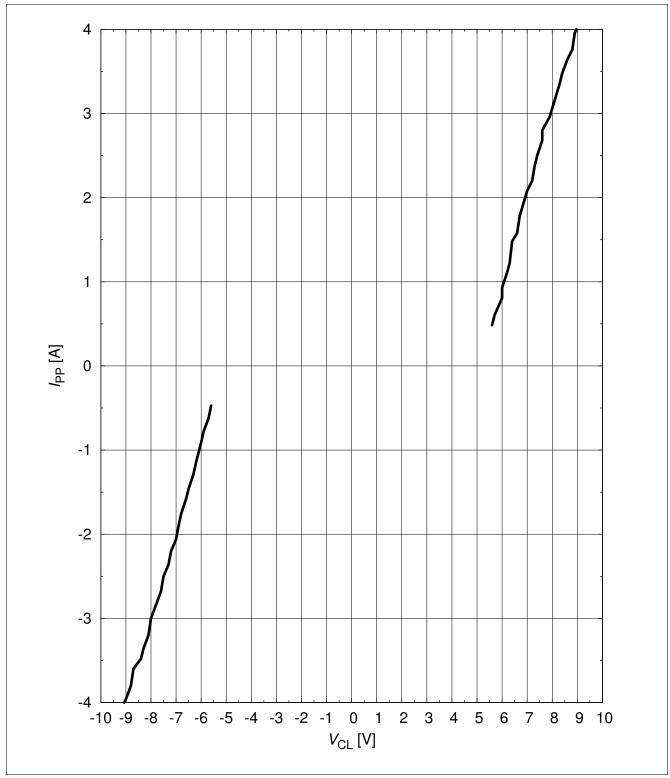


Figure 4-10 Clamping voltage (Surge):  $I_{PP} = f(V_{CL})$  [1], pin 1 to pin 2



**Package Information** 

### 5 Package Information

### 5.1 TSSLP-2-4

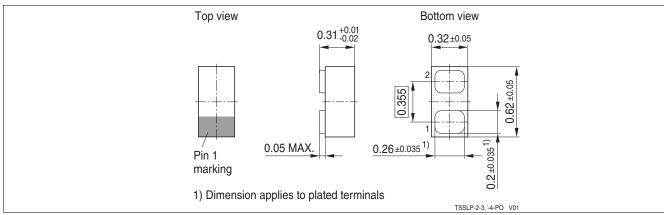


Figure 5-1 TSSLP-2-4 Package outline (dimension in mm)

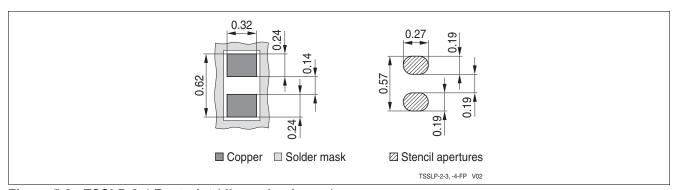


Figure 5-2 TSSLP-2-4 Footprint (dimension in mm)

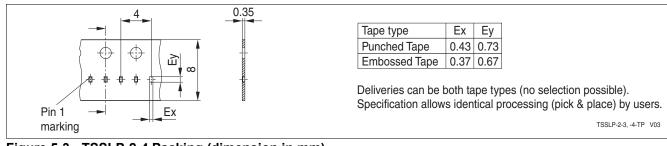


Figure 5-3 TSSLP-2-4 Packing (dimension in mm)

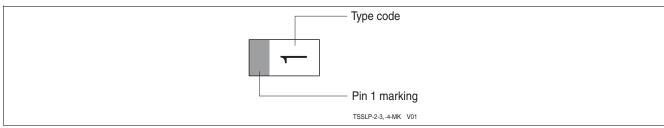


Figure 5-4 TSSLP-2-4 Marking example Table 1-1 "Part Information" on Page 3



**Package Information** 

### 5.2 TSLP-2-20

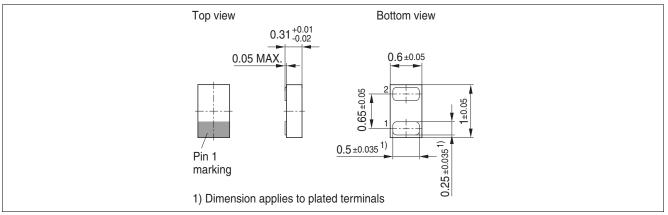


Figure 5-5 TSLP-2-20 Package outline (dimension in mm)

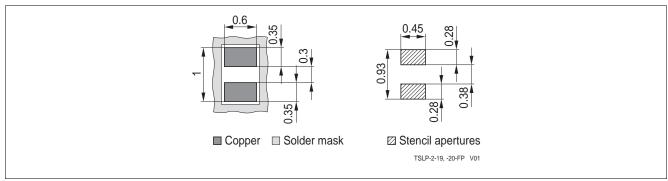


Figure 5-6 TSLP-2-20 Footprint (dimension in mm)

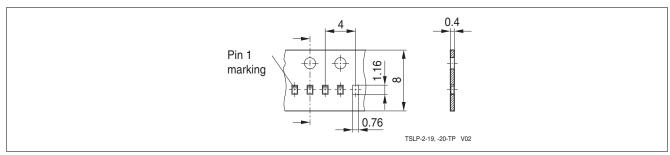


Figure 5-7 TSLP-2-20 Packing (dimension in mm)

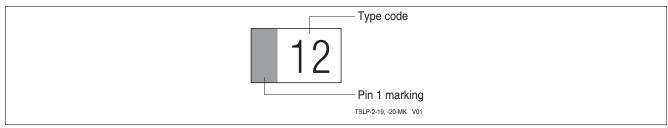


Figure 5-8 TSSLP-2-4 Marking example Table 1-1 "Part Information" on Page 3



References

### References

- [1] Infineon AG **Application Note AN210:** Effective ESD Protection Design at System Level Using VF-TLP Characterization Methodology
- [2] Infineon AG Recommendations for PCB Assembly of Infineon TSLP and TSSLP Package



Revision History: Rev.1.1, 2013-02-06				
Page or Item	Subjects (major changes since previous revision)			
Revision 1.2, 2	2014-05-14			
All	New type ESD113-B1-02EL inserted			

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